

	Type	L #	Hits	Search Text	DBs
1	BRS	L1	78254 5	(determin\$5 or detect\$5 or inspect\$5 or test\$5 or measur\$5) near7 (object or workpiece or (work adj1 piece) or surface or article)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
2	BRS	L2	8783	(modulat\$5 or chopp\$5) with ((reference near2 (beam or light or signal)) and (test\$5 or output\$5 or signal) near2 (beam or light or signal))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
3	BRS	L3	7374	(reflect\$5 near3 back) with (\$5sensor or \$5detector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
4	BRS	L4	72	1 and 2 and 3 and @ad<=20010215	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
5	BRS	L5	50	4 and amplif\$6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
6	BRS	L6	46	5 not wafer	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
7	BRS	L7	1352	(determin\$5 or detect\$5 or inspect\$5 or test\$5 or measur\$5) near4 (retroreflect\$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
8	BRS	L8	4	7 and 2 and 3 and @ad<=20010215	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
9	BRS	L9	9542	(reflect\$5 near8 back) with (\$5sensor or \$5detector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
10	BRS	L10	9245	(modulat\$5 or chopp\$5) with ((reference near2 (beam or light or signal)) and (test\$5 or output\$5 or signal or measur\$5) near2 (beam or light or signal))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
11	BRS	L11	7	7 and 9 and 10 and @ad<=20010215	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB